IPB50R199CP

CoolMOS™ Power Transistor

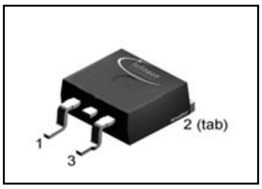
Features

- Lowest figure of merit R_{ON} x Q_g
- Ultra low gate charge
- Extreme dv/dt rated
- High peak current capability
- Pb-free lead plating; RoHS compliant; Halogen free for mold compound
- Qualified for industrial grade applications according to JEDEC[1)]

Product Summary

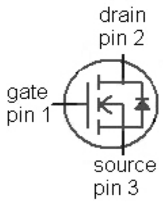
V_{DS} @T_{jmax}	550	V
$R_{DS(on),max}$	0.199	Ω
$Q_{g,typ}$	34	nC

PG-TO263



CoolMOS CP is designed for:

- Hard & soft switching SMPS topologies
- CCM PFC for ATX, Notebook adapter, PDP and LCD TV
- PWM for ATX, Notebook adapter, PDP and LCD TV



Type	Package	Marking
IPB50R199CP	PG-TO263	5R199P

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	T_C=25 °C	17	A
		T_C=100 °C	11	
Pulsed drain current[2)]	$I_{D,pulse}$	T_C=25 °C	40	
Avalanche energy, single pulse	E_{AS}	I_D=6.6 A, V_{DD}=50 V	436	mJ
Avalanche energy, repetitive t_{AR}[2),3)]	E_{AR}	I_D=6.6 A, V_{DD}=50 V	0.66	
Avalanche current, repetitive t_{AR}[2),3)]	I_{AR}		6.6	A
MOSFET d*v*/d*t* ruggedness	d*v*/d*t*	V_{DS}=0...400 V	50	V/ns
Gate source voltage	V_{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P_{tot}	T_C=25 °C	139	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	I_S	T_C=25 °C	9.9	A
Diode pulse current[2]	$I_{S,pulse}$		40	
Reverse diode dv/dt[4]	dv/dt		15	V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	0.9	K/W
Thermal resistance, junction - ambient	R_{thJA}	SMD version, device on PCB, minimal footprint	-	-	62	
		SMD version, device on PCB, 6 cm^2 cooling area[5]	-	35	-	
Soldering temperature, wave & reflow soldering allowed	T_{sold}	reflow MSL1	-	-	260	°C
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=250 µA	500	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=0.66 mA	2.5	3	3.5	
Zero gate voltage drain current	I_{DSS}	V_{DS}=500 V, V_{GS}=0 V, T_j=25 °C	-	-	1	µA
		V_{DS}=500 V, V_{GS}=0 V, T_j=150 °C	-	10	-	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=9.9 A, T_j=25 °C	-	0.18	0.199	Ω
		V_{GS}=10 V, I_D=9.9 A, T_j=150 °C	-	0.45	-	
Gate resistance	R_G	f=1 MHz, open drain	-	2.2	-	Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=100 V, f=1 MHz	-	1800	-	pF
Output capacitance	C_{oss}		-	80	-	
Effective output capacitance, energy related6[)]	$C_{o(er)}$	V_{GS}=0 V, V_{DS}=0 V to 400 V	-	75	-	
Effective output capacitance, time related7[)]	$C_{o(tr)}$		-	160	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=400 V, V_{GS}=10 V, I_D=9.9 A, R_G=16.4 Ω	-	35	-	ns
Rise time	t_r		-	14	-	
Turn-off delay time	$t_{d(off)}$		-	80	-	
Fall time	t_f		-	10	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=400 V, I_D=9.9 A, V_{GS}=0 to 10 V	-	8	-	nC
Gate to drain charge	Q_{gd}		-	11	-	
Gate charge total	Q_g		-	34	45	
Gate plateau voltage	$V_{plateau}$		-	5.2	-	V
Reverse Diode						
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=9.9 A, T_j=25 °C	-	0.9	1.2	V
Reverse recovery time	t_{rr}	V_R=400 V, I_F=I_S, di_F/dt=100 A/µs	-	340	-	ns
Reverse recovery charge	Q_{rr}		-	4	-	µC
Peak reverse recovery current	I_{rrm}		-	24	-	A

[1)] J-STD20 and JESD22

[2)] Pulse width t_p limited by $T_{j,max}$

[3)] Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

[4)] $I_{SD} \leq I_D$, di/d$t \leq$200A/µs, V_{DClink}=400V, $V_{peak} < V_{(BR)DSS}$, $T_j < T_{jmax}$, identical low and high side switch

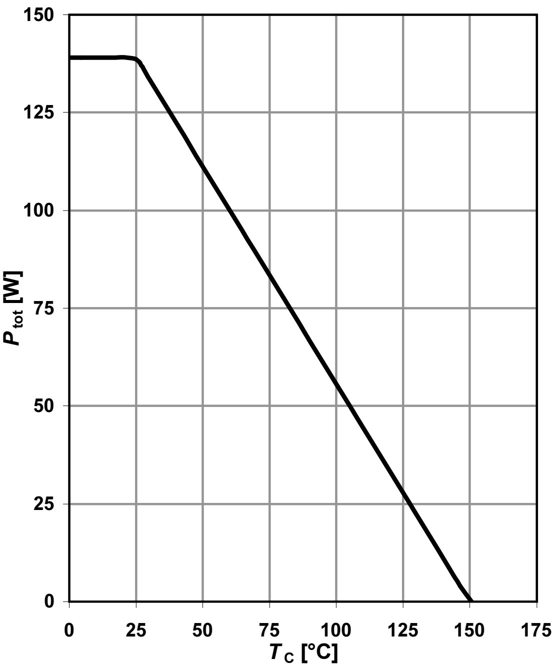
[5)] Device on 40mm*40mm*1.5 epoxy PCB FR4 with 6cm2 (one layer, 70µm thick) copper area for drain connection. PCB is vertical without blown air

[6)] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{DSS.}$

[7)] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{DSS.}$

1 Power dissipation

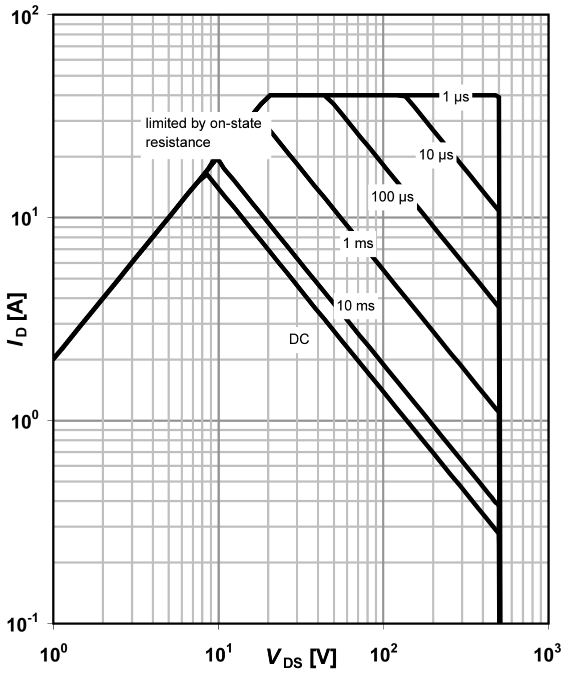
P_{tot}=f(T_C)



2 Safe operating area

I_D=f(V_{DS}); T_C=25 °C; D=0

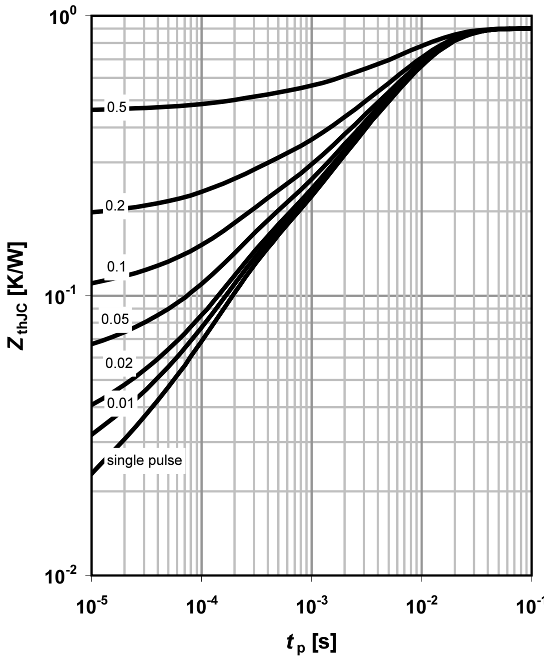
parameter: t_p



3 Max. transient thermal impedance

$Z_{(thJC)}$=f(t_p);

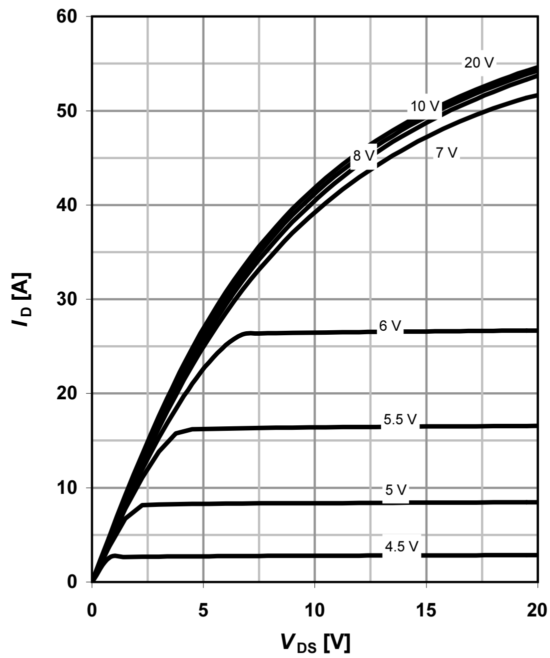
parameter: D=t_p/T



4 Typ. output characteristics

I_D=f(V_{DS}); T_j=25 °C

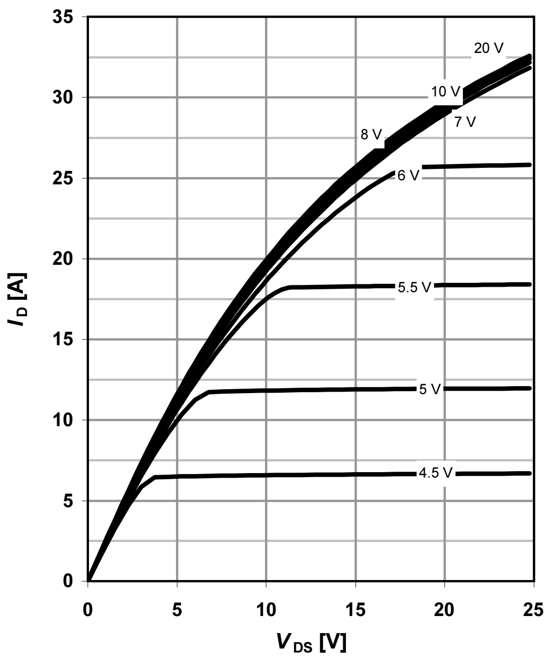
parameter: V_{GS}



5 Typ. output characteristics

I_D=f(V_{DS}); T_j=150 °C

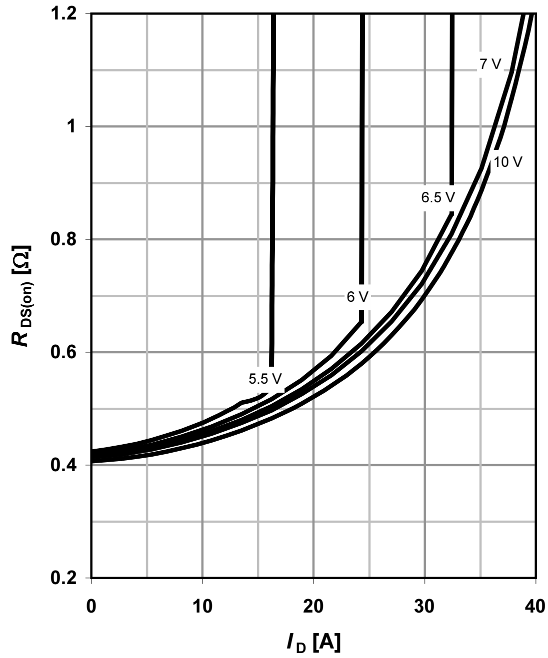
parameter: V_{GS}



6 Typ. drain-source on-state resistance

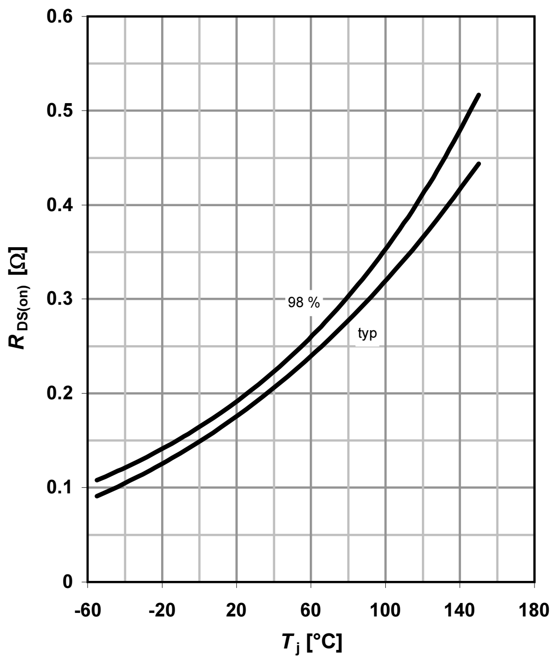
$R_{DS(on)}$=f(I_D); T_j=150 °C

parameter: V_{GS}



7 Drain-source on-state resistance

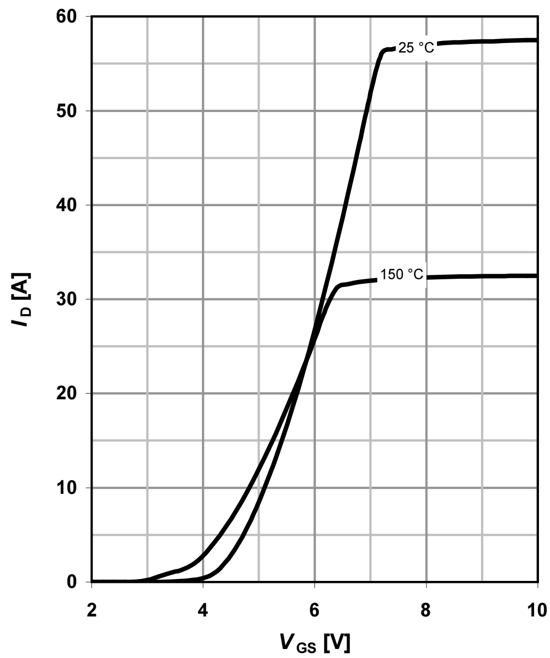
$R_{DS(on)}$=f(T_j); I_D=9.9 A; V_{GS}=10 V



8 Typ. transfer characteristics

I_D=f(V_{GS}); $|V_{DS}|>2|I_D|R_{DS(on)max}$

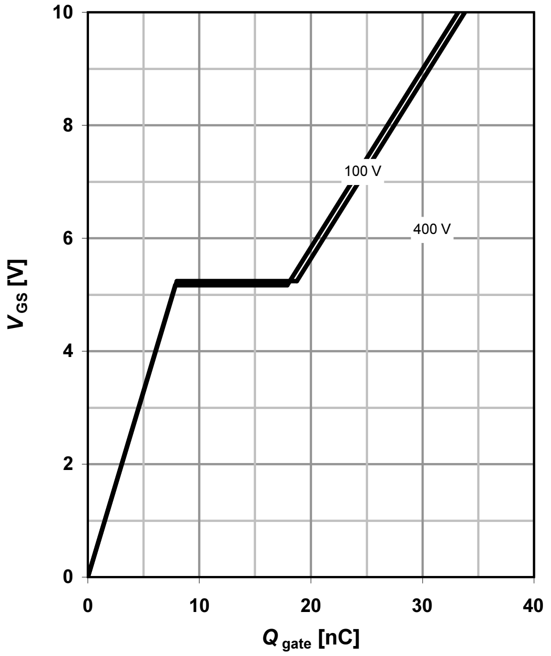
parameter: T_j



9 Typ. gate charge

V_{GS}=f(Q_{gate}); I_D=9.9 A pulsed

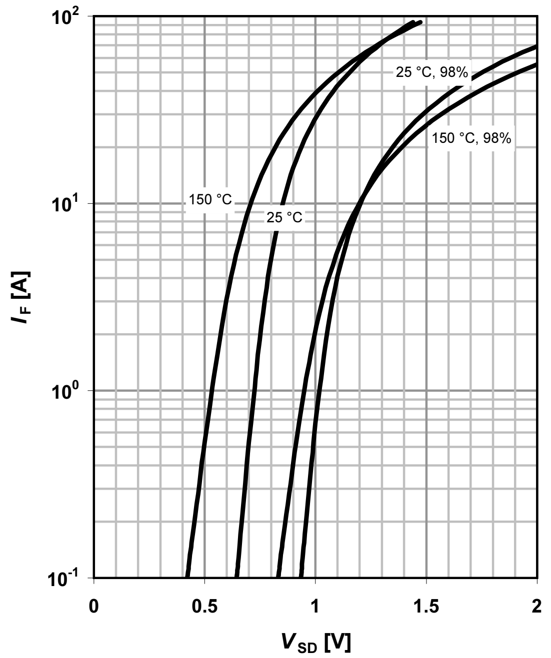
parameter: V_{DD}



10 Forward characteristics of reverse diode

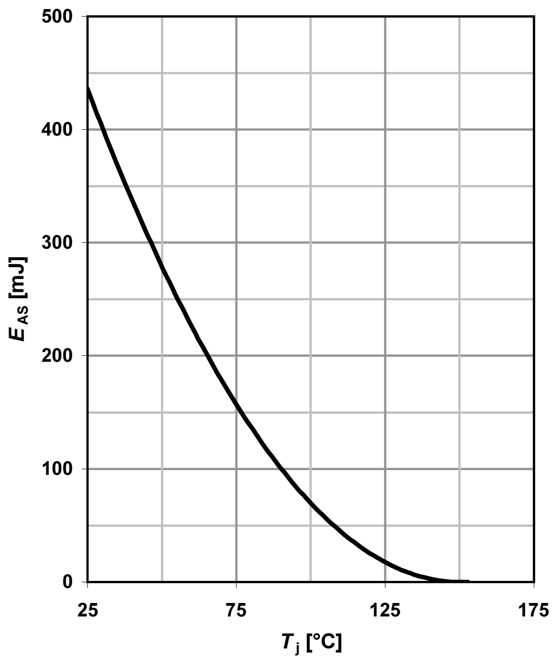
I_F=f(V_{SD})

parameter: T_j



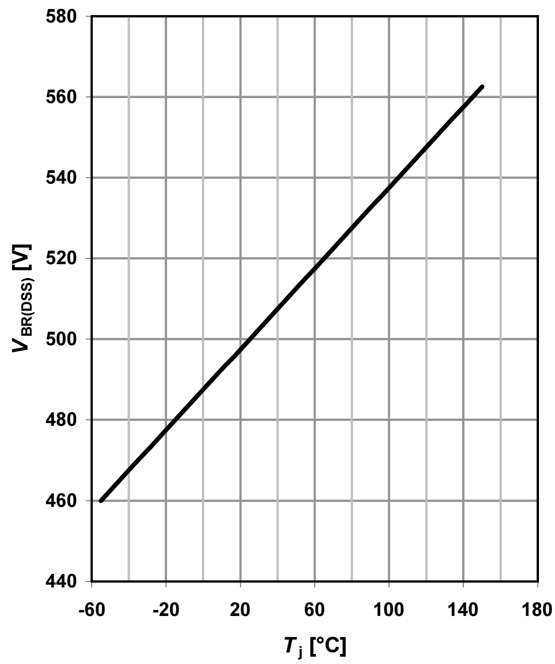
11 Avalanche energy

E_{AS}=f(T_j); I_D=6.6 A; V_{DD}=50 V



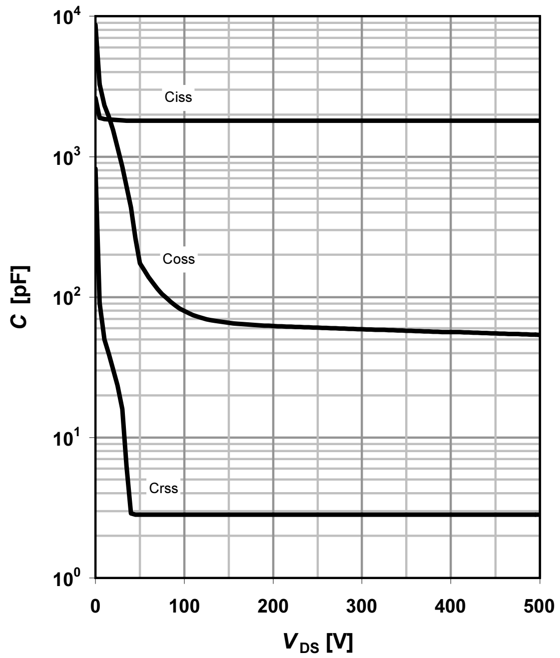
12 Drain-source breakdown voltage

$V_{BR(DSS)}$=f(T_j); I_D=0.25 mA



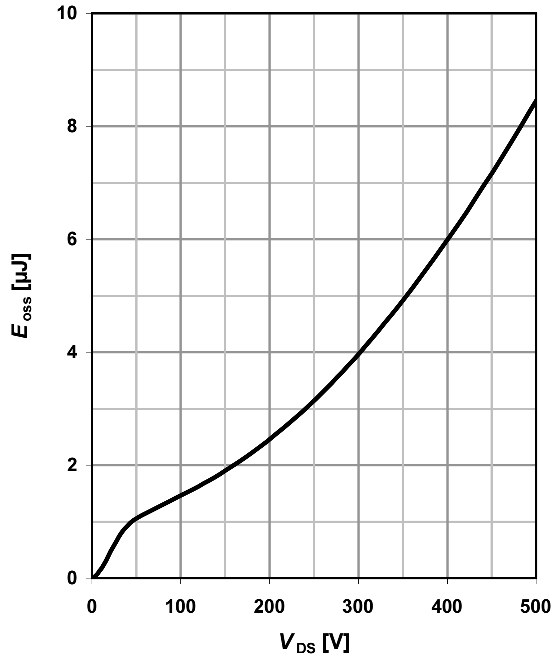
13 Typ. capacitances

$C=f(V_{DS})$; V_{GS}=0 V; f=1 MHz

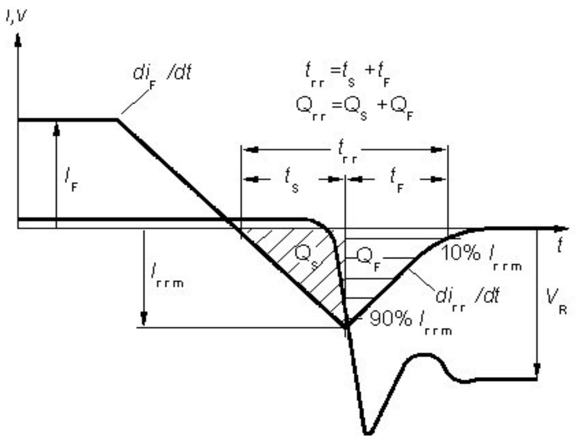


14 Typ. Coss stored energy

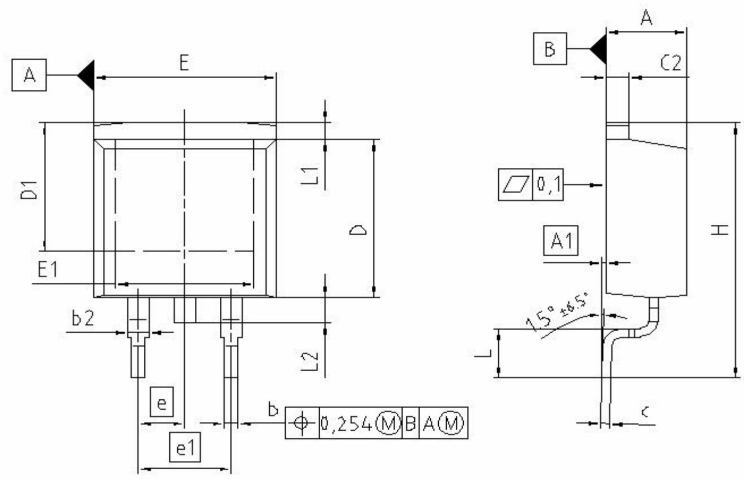
$E_{oss}=f(V_{DS})$



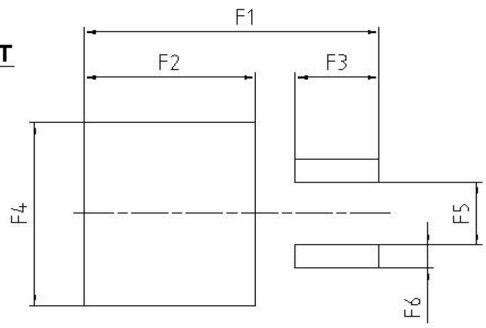
Definition of diode switching characteristics



PG-TO263-3-2: Outlines



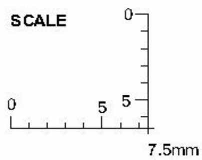
FOOTPRINT



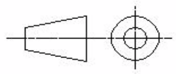
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.300	4.572	0.169	0.180
A1	0.000	0.254	0.000	0.010
b	0.650	0.850	0.026	0.033
b2	0.950	1.321	0.037	0.052
c	0.330	0.650	0.013	0.026
c2	0.170	1.400	0.046	0.055
D	8.509	9.450	0.335	0.372
D1	7.100	-	0.280	-
E	9.800	10.312	0.386	0.406
E1	6.500		0.256	
e	2.540		0.100	
e1	5.080		0.200	
N	2		2	
H	14.605	15.875	0.575	0.625
L	2.200	3.000	0.087	0.118
L1	-	1.600	-	0.063
L2	1.000	1.778	0.039	0.070
F1	16.050	16.250	0.632	0.640
F2	9.300	9.500	0.366	0.374
F3	4.500	4.700	0.177	0.185
F4	10.700	10.900	0.421	0.429
F5	3.630	3.830	0.143	0.151
F6	1.100	1.300	0.043	0.051

REFERENCE
JEDEC TO263

SCALE



EUROPEAN PROJECTION



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